Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/710,383	YAMADA, TAKASHI	
Examiner	Art Unit	
Nguyen N. Hanh	2834	

SEARCHED				
Class	Subclass	Date	Examiner	
310	194	6/7/2005	HN	
310	71	6/7/2005	HN	
310	258	6/7/2005	HN	
310	259	6/7/2005	HN	
310	316	6/7/2005	HN	
310	217	6/7/2005	HN	
310	218	6/7/2005	HN	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Consult Dang Le, Prim Examinur for allowance	my 6/7/05	HN		
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